

SANYO Semiconductors DATA SHEET

An ON Semiconductor Company

2SC6082 — NPN Epitaxial Planar Silicon Transistor 50V / 15A High-Speed Switching Applications

Applications

· High-speed switching applications (switching regulator, driver circuit)

Features

- · Adoption of MBIT process
- · Low collector-to-emitter saturation voltage
- · Large current capacitance
- · High-speed switching

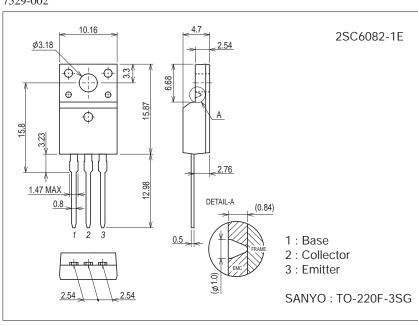
Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Collector-to-Base Voltage	V _{CBO}		60	V
Collector-to-Emitter Voltage	VCES		60	V
	VCEO		50	V
Emitter-to-Base Voltage	VEBO		6	V
Collector Current	IC		15	А
Collector Current (Pulse)	ICP	PW≤10μs, duty cycle≤1%	20	А
Base Current	IB		3	А
Collector Dissipation	Do		2	W
	PC	Tc=25°C	23	W
Junction Temperature	Tj		150	°C
Storage Temperature	Tstg		-55 to +150	°C

Package Dimensions

unit : mm (typ) 7529-002



Product & Package Information

• Package : TO-220F-3SG

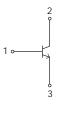
• JEITA, JEDEC : SC-67

• Minimum Packing Quantity

: 50 pcs./magazine

Marking Electrical Connection



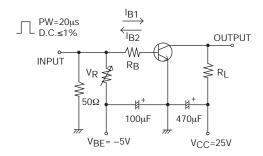


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Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Linit
Parameter	Symbol	Conditions	min	typ	max	Unit
Collector Cutoff Current	ICBO	V _{CB} =40V, I _E =0A			10	μΑ
Emitter Cutoff Current	I _{EBO}	V _{EB} =4V, I _C =0A			10	μΑ
DC Current Gain	hFE1	V _{CE} =2V, I _C =330mA	200		560	
DC Current Gain	h _{FE} 2	V _{CE} =2V, I _C =10A	50			
Gain-Bandwidth Product	fŢ	V _{CE} =10V, I _C =2A		195		MHz
Output Capacitance	Cob	V _{CB} =10V, f=1MHz		85		pF
Collector-to-Emitter Saturation Voltage	V _{CE} (sat)	I _C =7.5A, I _B =375mA		200	400	mV
Base-to-Emitter Saturation Voltage	V _{BE} (sat)	I _C =7.5A, I _B =375mA			1.2	V
Collector-to-Base Breakdown Voltage	V(BR)CBO	IC=100μA, IE=0A	60			V
Collector-to-Emitter Breakdown Voltage	V(BR)CES	IC=100μA, RBE=0Ω	60			V
Collector-to-Efflitter Breakdown voltage	V(BR)CEO	IC=1mA, RBE=∞	50			V
Emitter-to-Base Breakdown Voltage	V(BR)EBO	I _E =100μA, I _C =0A	6			V
Turn-On Time	ton			52		ns
Storage Time	t _{Stg}	See specified Test Circuit		560		ns
Fall Time	tf			37		ns

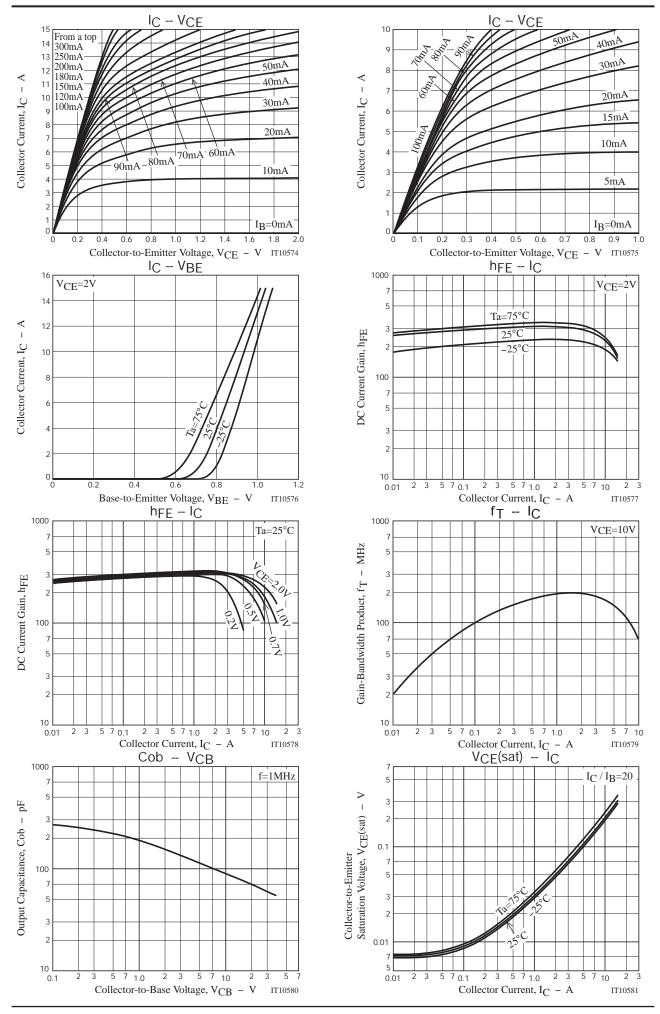
Switching Time Test Circuit

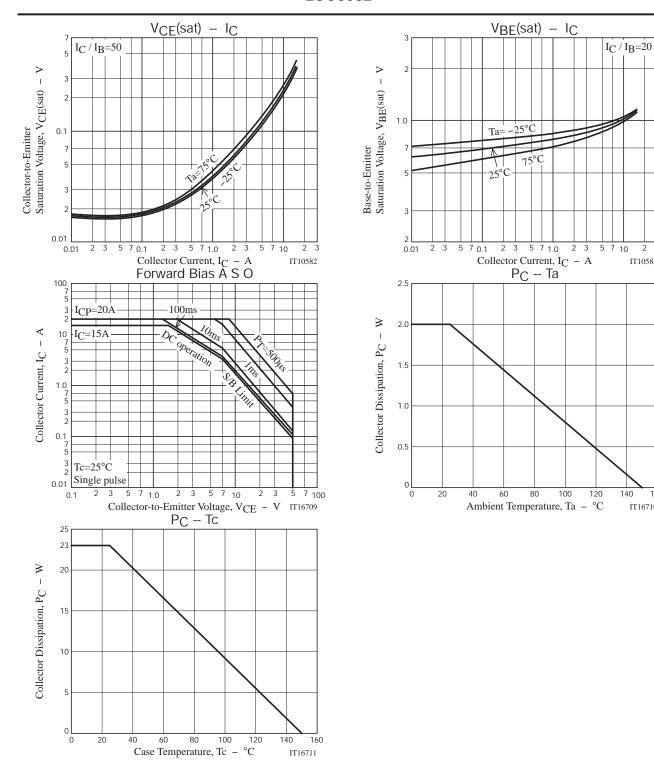


 $I_{C}=20I_{B1}=-20I_{B2}=5A$

Ordering Information

Device	Package	Shipping	memo
2SC6082-1E	TO-220F-3SG	50pcs./magazine	Pb Free





IT10583

140

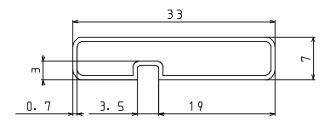
160 IT16710

Magazine Specification

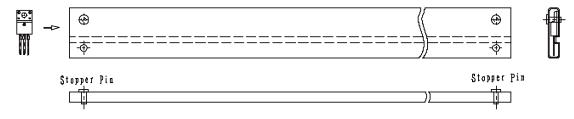
2SC6082-1E

1. Packing Format

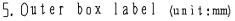
Package Name Magazine Name		Maximum Number of devices contained (pcs)			Packing format		
1 4 4 4 4 4 1 4 4 4 4	Idag as the Hams	l	Inner box	Outer box	Inner BOX	Outer BOX	
TO-220F-3SG	TO-220F	50	1, 000	4,000	SPD-0V0001 20 magazines contained Dimensions:mm (external) 568×150×55	SPT-081029 4 inner boxes contained Dinensions:mm (external) 590×225×178	



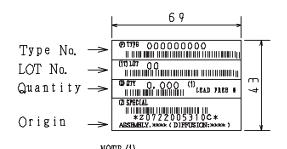
3. Storage method to magazine

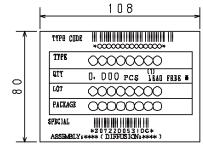


4. Inner box label (unit:mm)



It is a label at the time of factory shipments. The form of a label may change in physical distribution process.



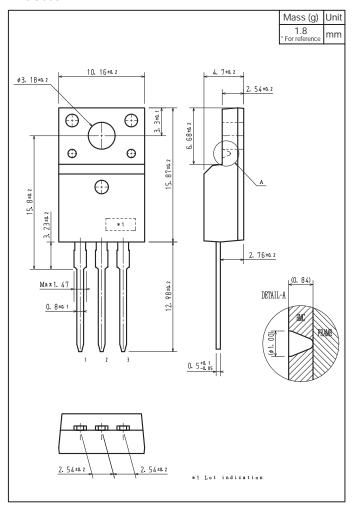


NOTE(1)
The LEAD FREE * description shows that the surface treatment of the terminal is lead free.

Label		JEITA Phase			
LEAD FREE	3	JEITA Phase 3A			

Outline Drawing

2SC6082-1E



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